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Form PTO- 1449	COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DKT. NO. ASA-1236	SERIAL NO. 10/533,127		
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## **U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
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# FOREIGN PATENT DOCUMENTS

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/VN/	AU	Proc. of IEEE International Works March. 2001.	Supply Current Test", by Masaki HASHIZUME, et al., hop on Defect Based Testing, pp. 509-513, publ.
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		FILING DATE April 29, 2005	GROUP

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